


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578133	<b>Applicant(s)/Patent Under Reexamination</b>  SHIN ET AL.
	<b>Examiner</b>  Leigh C Maier	<b>Art Unit</b>  1623

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	1/26/09	LCM
EAST	10/9/09	LCM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	54	10/23/09	LCM

	/Leigh C Maier/ Primary Examiner.Art Unit 1623
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